

<b>Notice of References Cited</b>	Application/Control No. 10/732,712	Applicant(s)/Patent Under Reexamination ZHENG, TIEYU	
	Examiner Derek L. Dupuis	Art Unit 2883	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,666,450	09-1997	Fujimura et al.	385/93
*	B	US-4,418,264	11-1983	Thorwarth, Ruediger	219/78.01
*	C	US-4,386,821	06-1983	Simon et al.	385/92
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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